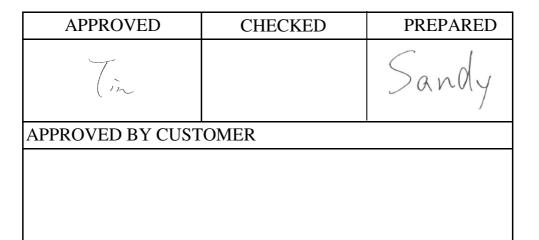
APPROVAL SHEET

Customer Name	:		
Customer P/N	:		
Frequency	:	50.000000	MHz
Aker Approved P/N	:	SMB-050000-7BL4A6	
Aker MPN	:	SMB-050000-7BL4A6	
Rev.	:	1	
ISSUE DATE	:	Nov.26.2019	



AKER TECHNOLOGY CO., LTD.

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Web: www.aker.com.tw

RoHS compliant



CUST. P/N	•		
Aker Approved	P/N :	SMB-05	0000-7BL4A6
APPROVED	•	Tin	SHEET : 1 of 10
PREPARED	:	Sandy	REV. : 1

Rev.	Date	Reviser	Revise contents
1	2019/11/26	Sandy	Initial Released



	CUST. P/N	:		
	Aker Approved P/N	:	SMB-0500	00-7BL4A6
	APPROVED	:	Tin	SHEET : 2 of 10
Kinetic Energy	PREPARED	•	Sandy	REV. : 1
			-	

SMD CRYSTAL OSCILLATOR

1. ELECTRICAL CHARACTERISTICS

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature : 25±5 ℃

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : 25±3 °C

Relative humidity : $40\% \sim 70\%$

AKER Model : SMB-751

• Cutting Model : AT CUT

		Electrical Spec				
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes
Nominal Frequency		5	0.00000	0	MHz	
Frequency Stability			±50		ppm	
Supply Voltage	Vcc	,	3.3±10%)	V	
Output Load CMOS	CL		15		pF	
Aging			±3		ppm	First Year
Enable Control			Yes			Pad 1
Operating Temperature		-40	25	85	°C	
Storage Temperature Range		-55	~	125	°C	
Output Voltage High	VoH	90%Vdd			V	
Output Voltage Low	VoL			10%Vdd	V	
Input Current	Icc			25	mA	
Standby Current	Ist			10	μA	
Rise Time	Tr			8	ns	10%~90%VDD Level
Fall Time	Tf			8	ns	10%~90%VDD Level
Symmetry (Duty ratio)	TH/T	40	~	60	%	
Start-up Time	Tosc			10	ms	
Enable Voltage High	Vhi	70%Vdd			V	
Disable Voltage Low	Vlo			30%Vdd	V	
Output Enable Delay Time	T on			10	ms	
Output Disable Delay Time	T off			150	ns	
Phase Jitter RMS				1	ps	12KHz~20MHz
Please kindly be noted that AKER	DO NOT g	uarantee p	arts qualit	y which in	volves	human security application.



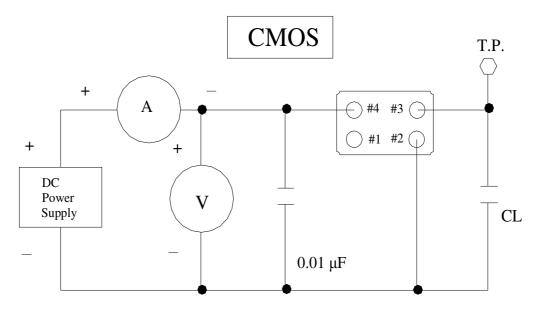
	CUST. P/N	•		
	Aker Approved P/N	:	SMB-0500	000-7BL4A6
	APPROVED	:	Tin	SHEET : 3 of 10
Accurate Kinetic Energy	PREPARED	:	Sandy	REV. : 1
2.C-MOS LOAD OUTPU	T WAVEFORM			
"1"Level			9	VDD 0% VDD 0% VDD
"0"Level		<u> </u>	====10	0% VDD

GND

3.C-MOS LOAD TEST CIRCUIT

TW

Т



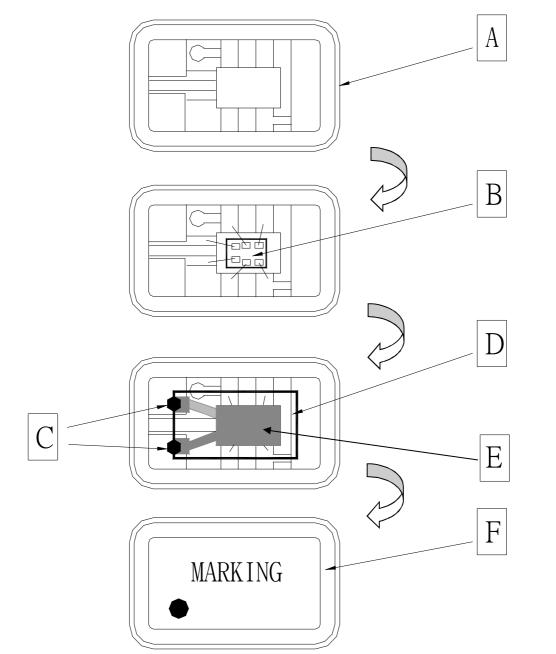
***Because SMA series has no by pass capacitor. So, we recommend our customer to use capacitor $0.01 \ \mu F$ in join Vcc and GND.

		CUS	T. P/N					
			Aker Approved P/N : SMB-050000-7BL4A6					
			ROVED	:	Tin		SHEET :	
/	Accurate Kinetic Energy		PARED	•			REV. :	
4 . MA	4. MARKING :							
	$ \begin{array}{c c} L50.000 & \longrightarrow & Voltage Note1 & FREQUENCY\\ \bullet AKER AL & & & & \\ \end{array} $							
		Year/	Month Co	ode: Plea	ase make 1	refer to fo	ollowing ta	ables.
↓		code ₁		2010	2020	2021	2022	1
Pin1	KER LOGO.		Year	2019 2023	2020 2024	2021 2025	2022 2026	-
Ar NOTE1:				2025	2024	2029	2020	-
			Month	2031	2032	2033	2034]
T	5.0V TTL			2035	2036	2037	2038	-
С	4.5~5.0V CMOS		JAN FEB	A B	N P	a b	n p	-
L	2.97~3.63V TTL&CMOS		MAR	C	Q	c	q	-
			APR	D	R	d	r	
R	2.8~3.0V CMOS		MAY	E	S	e	s	-
S	2.25~2.75V CMOS		JUN JUL	F G	T U	f g	t u	-
Y	1.5~2.0V CMOS		AUG	H	v	h	v	
			SEP	J	W	j	w	-
Z	0.8~1.4V CMOS		OCT NOV	K L	X Y	<u>k</u>	x y	-
W	Voltage Range CMOS		DEC	M	Z	m	z	
5 . DIN	IENSION :	-	<to 7.0 ± #4</to 	DP> : 0.15 #3	<u>Cerami</u> Met	<side c Base tal Lid</side 		NIT : mm)
Enable /	Disable Function	5.0±0.15	AK ●	ER			C	
E/D (#1)) OUTPUT(#3)	!	#1	#2		Ľ	」 【_	
HIGH (O	open) Operating					1.4 M	ax.	
LOW	High impedance		<bot 5.</bot 	TOM>	<s< th=""><th>UGGESTED</th><th></th><th></th></s<>	UGGESTED		
DIME	UNCTION		#1	#2				
	UNCTION				-			
	#1 : Enable / Disable Control #2 : GND				4.20	v <i>///////</i> >	<u>×11/11/11/1</u> 2	
#2 GF #3 : OL	2.60						0	
#3 . 01 #4 : VI			L ////	J #3	_ ∹ _			2.0
₩•• • VL			→ ^{**} → 1.4		1			
							1.8	



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APPROVED	:	Tin	SHEET : 5 of 10
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6. STRUCTURE ILLUSTRATION



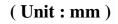
	COMPONENTS	MATERIALS	COMPONENTS		MATERIALS
A	Base (Package)	Ceramic (Al2O3)+Kovar (Fe/Co/Ni)	D	Crystal blank	SiO2
В	IC chip		E	Electrode	Cr / Ag
С	Conductive adhesive	Ag / Silicon resin	F	Lid	Fe/Co/Ni

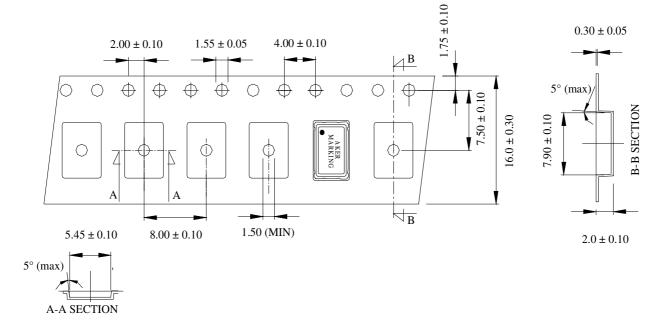


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APPROVED	•	Tin	SHEET : 6 of 10
PREPARED	:	Sandy	REV. : 1

7. PACKING :

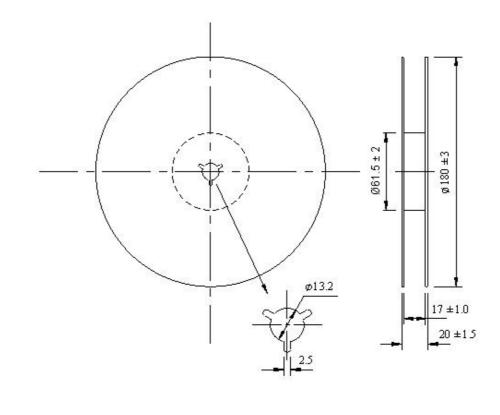
TAPE SPECIFICATION

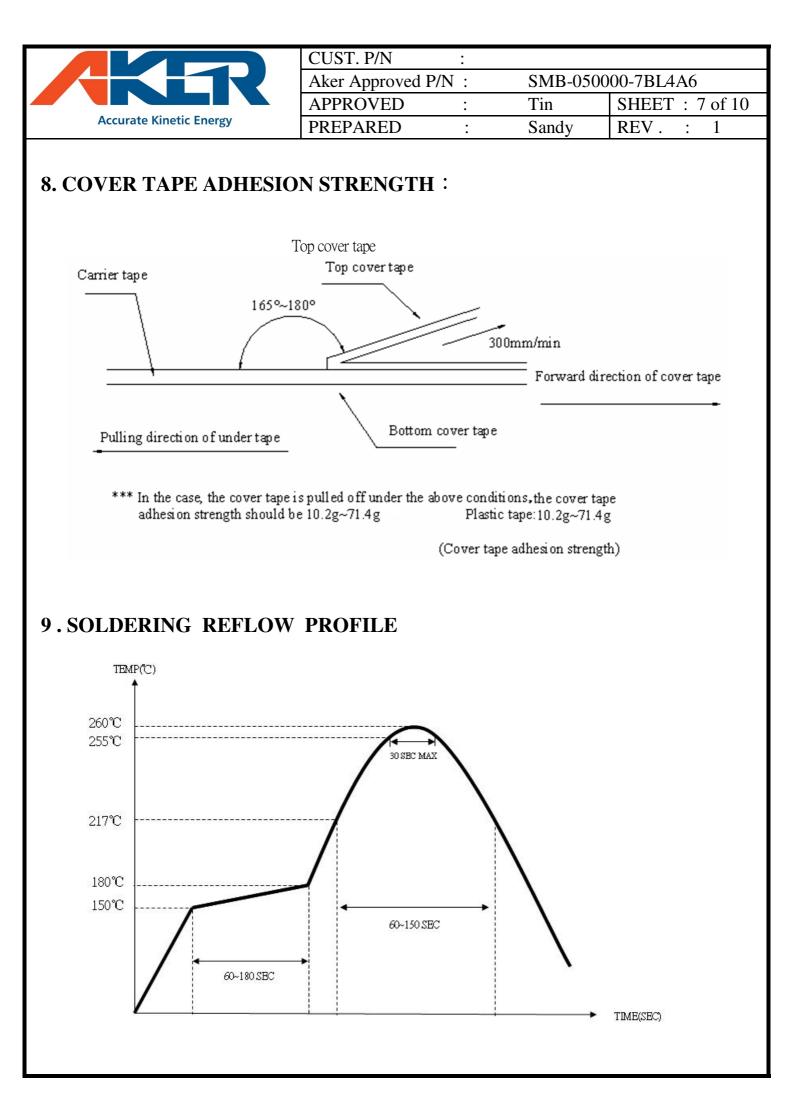


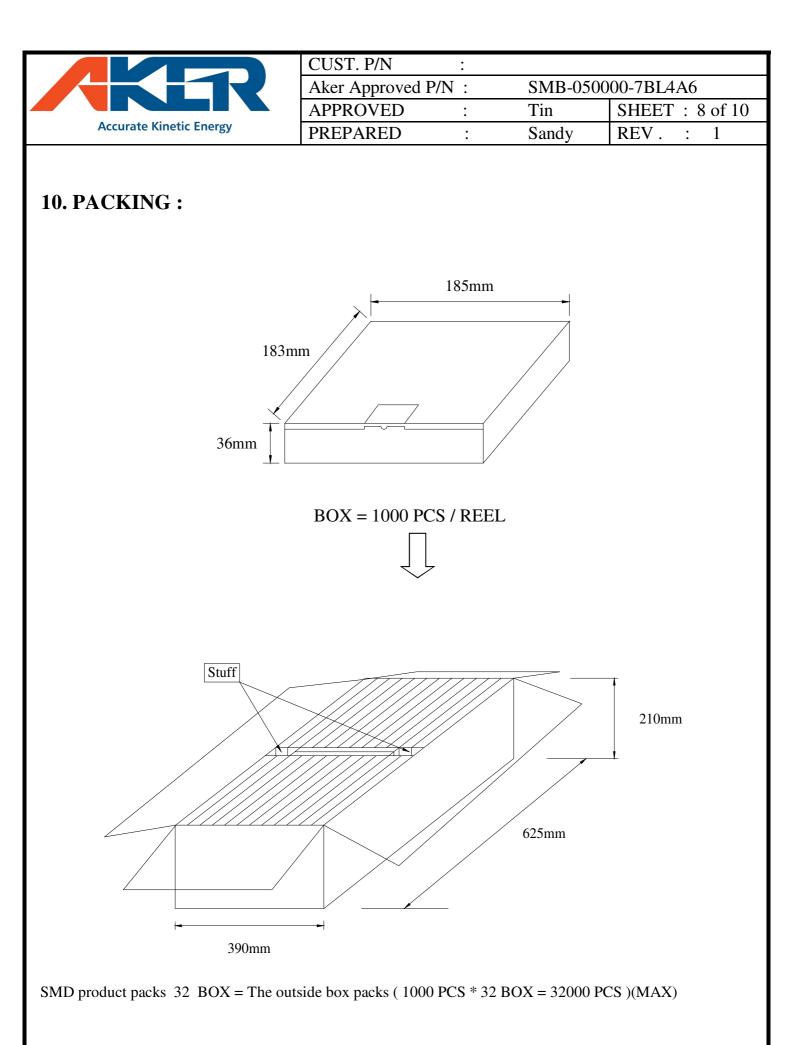


OUTLINE DIMENSION

(Unit:mm)









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APPROVED	:	Tin	SHEET : 9 of 10
PREPARED	•	Sandy	REV. : 1

11. MECHANICAL PERFORMANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a hight of 100 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. (in accordance with JIS-C0044)	
11.2 Vibration Test	The specimen is measured for its frequency before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range ; 20 ~ 2000HZ Peak to peak amplitude : 1.52 mm Peak acceleration : 20G Sweep time : 20 minute / axis Pendicular total test time : 4 hours	To satisfy the electrical performance .
11.3 Resistance to Soldering Test	(in accordance with MIL-STD-883F : 2007.3) The specimen is measured for its frequency before the test. Place the specimen on	
11.4 Fine Leak	the belt of the converynace and let it pass through the reflow with the presetted temperature condition. After passing twice the reflow place, the specimen under the referee condition for -~2 hours and then measure its electrical performance. Temperature Condition of IR Simulation: The temperature range of the preheated section is setted at 150 $^{\sim}$ 180°C for 60~120 sec. For the next section the temperature range is setted at 217~260°C for 45~90 sec. and within this time range the specimen should be able to sustain at the peak temperature, 260+/-3°C , for 10 sec long. (in accordance with JESD22-B106-B) Place the specimen in a pressurized container and	
Test	pressurize it with the detection gas (mixed gas consisting of 95% or more helium) for at least 2 hours. Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container.	Less than 1.0 * 10 ⁻⁸ atm .c.c. / sec, Helium
	(in accordance with MIL-STD-883F : 1014.11) The referee condition . Temperature 25 ± 2 °C Humidity $44 \ 55 \%$ Pressure $86 \ 106$ kPa (in accordance with MIL-STD-883E : 1014.9)	



CUST. P/N	•		
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12. CLIMATIC RESISTANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	The specimen is measured for its frequency before the test . Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for 168 ± 6 hours . Take the specimen out of the chamber and measure itselectrical performance after leaving 1 ~ 2 hours under the referee condition. (in accordance with JIS-C0020)	
12.2 Aging Test	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and keep it at the temperature of $+ 125 \pm 3^{\circ}$ C for 720 ± 48 hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition . (in accordance with JIS-C0021)	To satisfy the electrical performance .
12.3 High Temperature & High Humidty	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5$ °C and humidity of 85 ± 5 % for 168 ± 6 hours.and then take the specimen out and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition. (in accordance with MIL-STD-883F : 1004.7)	
12.4 Temperature Cycle Test	The specimen is measured for its frequency before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + 125 ± 3 °C (15± 3 min). $2\sim 3 \text{ min}$ $2\sim 3 \text{ min}$. Low temp55 ± 3 °C (15± 3 min). Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . (in accordance with MIL-STD-883F : 1010.8)	